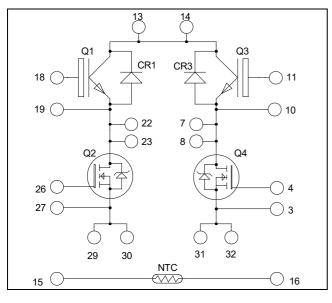


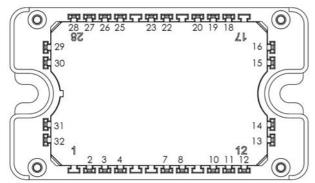
Full - Bridge Power module

Trench & Field Stop IGBT3 Q1, Q3: $V_{CES} = 600V$; $I_C = 50A$ @ $T_C = 80$ °C

Super Junction MOSFET Q2, Q4: $V_{DSS} = 600V$; $I_D = 49A$ @ $T_C = 25^{\circ}C$



Top switches: Trench + Field Stop IGBT3 Bottom switches: Super junction MOSFET



All multiple inputs and outputs must be shorted together 13/14; 22/23; 29/30; 31/32

Application

Solar converter

Features

- Q2, Q4 Super junction MOSFET
 - Ultra low R_{DSon}
 - Low Miller capacitance
 - Ultra low gate charge
 - Avalanche energy rated
- Q1, Q3 Trench & Field Stop IGBT3
 - Low voltage drop
 - Switching frequency up to 20 kHz
 - RBSOA & SCSOA rated
 - Low tail current
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Optimized conduction & switching losses
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS Compliant**

All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed.

1. Top switches

1.1 Top Trench + Field Stop IGBT3 characteristics

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit	
V_{CES}	Collector - Emitter Voltage		600	V
$I_{\rm C}$	Continuous Collector Current	$T_C = 25^{\circ}C$	80	
	Continuous Collector Current $T_C =$	$T_C = 80^{\circ}C$	50	A
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_D	Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_J = 150$ °C	100A @ 550V	

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μΑ
17	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C		1.5	1.9	W
$V_{\text{CE(sat)}}$		$I_C = 50A$	$T_j = 150$ °C		1.7		v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 600 \mu A$		5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	= 0V			600	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	r .	Min	Typ	Max	Unit
C_{ies}	Input Capacitance	$V_{GE} = 0V$			3150		
C_{oes}	Output Capacitance	$V_{CE} = 25V$			200		pF
C_{res}	Reverse Transfer Capacitance	f = 1MHz			95		
$T_{d(on)} \\$	Turn-on Delay Time	Inductive Switc	hing (25°C)		110		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$			45]
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 300 \text{ V}$ $I_{\text{C}} = 50 \text{A}$	$V_{\text{Bus}} = 300\text{V}$		200		ns
T_{f}	Fall Time	$R_G = 8.2\Omega$		40			
$T_{d(on)}$	Turn-on Delay Time		Inductive Switching (150°C)		120		
T_{r}	Rise Time	$V_{GE} = \pm 15V$			50		ns
$T_{d(off)} \\$	Turn-off Delay Time	$V_{\text{Bus}} = 300V$ $I_{\text{C}} = 50A$			250		
T_{f}	Fall Time	$R_G = 8.2\Omega$			60		
E	Trum on Creitalina Engage	$V_{GE} = \pm 15V$	$T_j = 25^{\circ}C$		0.3		T
Eon	Turn-on Switching Energy	$V_{\text{Bus}} = 300 \text{V}$	$T_j = 150$ °C		0.43		mJ
E_{off}	Turn-off Switching Energy	$I_C = 50A$	$T_j = 25^{\circ}C$		1.35		mJ
Loff	Turn-off Switching Energy $R_G = 8.2\Omega$	$T_j = 150$ °C		1.75		1113	
R_{thJC}	Junction to Case Thermal resistance					0.85	°C/W

1.2 Top fast diode characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					600	V
I_{RM}	Reverse Leakage Current	V _R =600V				25	μA
I_{F}	DC Forward Current		$Tc = 80^{\circ}C$		30		A
	Diode Forward Voltage	$I_F = 30A$			1.8	2.3	
V_{F}		$I_F = 60A$			2.1		V
		$I_F = 30A$	$T_j = 125$ °C		1.5		
4	Reverse Recovery Time		$T_j = 25$ °C		25		44.0
t_{rr}		$I_F = 30A$ $V_R = 400V$	$T_j = 125$ °C		160		ns
0	Reverse Recovery Charge	$v_R = 400 \text{ V}$ $di/dt = 200 \text{A/}\mu\text{s}$	$T_j = 25$ °C		35		пC
Q_{rr}		,	$T_j = 125$ °C		480		пС
R_{thJC}	Junction to Case Thermal resistance		_			1.2	°C/W

2. Bottom switches

2.1 Bottom Super junction MOSFET characteristics

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V_{DSS}	Drain - Source Voltage		600	V
T_	Continuous Drain Current		49	
I_D	Continuous Diani Current	$T_c = 80^{\circ}C$	38	A
I_{DM}	Pulsed Drain current		130	
V_{GS}	Gate - Source Voltage	±20	V	
R_{DSon}	Drain - Source ON Resistance	45	$m\Omega$	
P_D	Power Dissipation	$T_c = 25$ °C	290	W
I_{AR}	Avalanche current (repetitive and non repetitive)	15	A	
Ear	Repetitive Avalanche Energy	3	mJ	
E_{AS}	Single Pulse Avalanche Energy	1900	1113	

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 600V$			250	μΑ
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 24.5A$		40	45	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 3mA$	2.1	3	3.9	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA



Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
Ciss	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 25V$		7.2		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		0.29		III.
Q_{g}	Total gate Charge	$V_{GS} = 10V$		150		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 300V$		34		пC
Q_{gd}	Gate – Drain Charge	$I_D = 49A$		51		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		21		
T_{r}	Rise Time	$V_{GS} = 10V$		30		ns
$T_{d(off)} \\$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{D}} = 49A$		100		
T_{f}	Fall Time	$R_G = 4.7\Omega$		45		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		675		1
E _{off}	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 400V$ $I_D = 49A ; R_G = 4.7\Omega$		520		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		1100		1
E _{off}	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 400V$ $I_D = 49A ; R_G = 4.7\Omega$		635		μJ
R_{thJC}	Junction to Case Thermal resistance				0.5	°C/W

3. Temperature sensor (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100$ °C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$

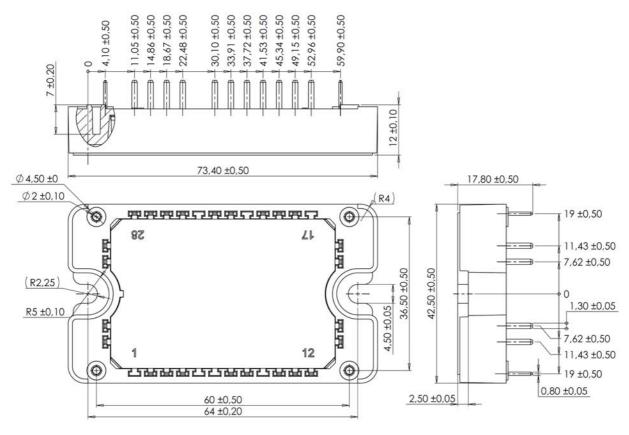
T: Thermistor temperature R_T: Thermistor value at T

4. Package characteristics

Symbol	Characteristic			Min	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz					V
$T_{\rm J}$	Operating junction temperature range			-40	150*	
T_{JOP}	Recommended junction temperature under switching conditions			-40	T _J max -25	°C
T_{STG}	Storage Temperature Range			-40	125	
$T_{\rm C}$	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

Tj=175°C for IGBT

5. Package outline (dimensions in mm)

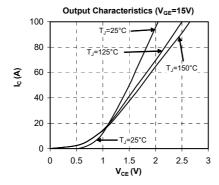


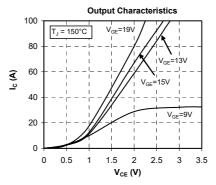
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

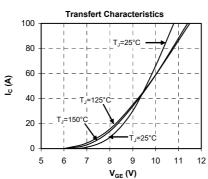


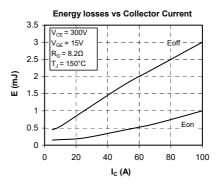
6. Top switches curves

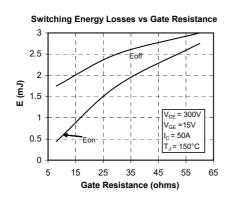
6.1 Top Trench + Field Stop IGBT3 typical performance curves

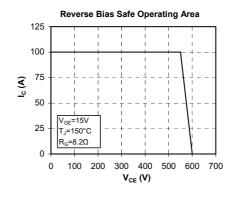


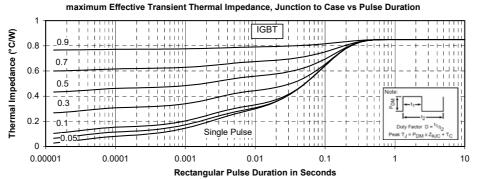












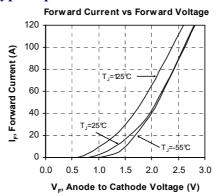
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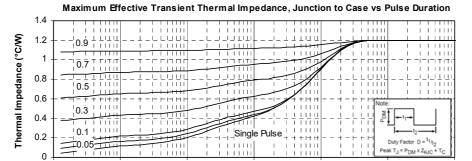
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APTCV50H60T3G

10

6.2 Top Fast diode typical performance curves





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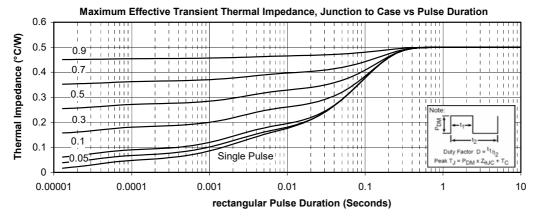
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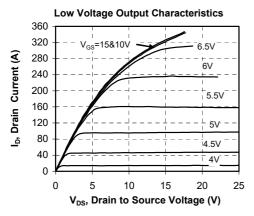
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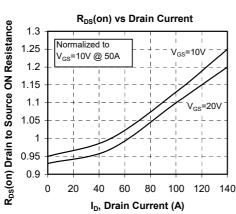


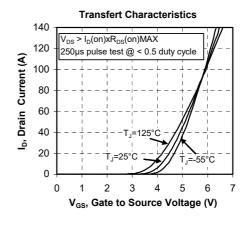
7. Bottom switches curves

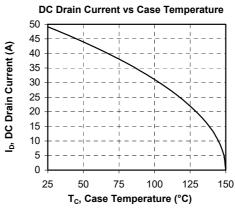
7.1 Bottom Super junction MOSFET typical performance curves



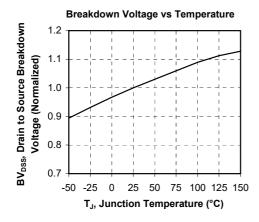


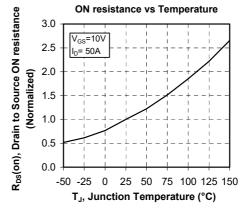


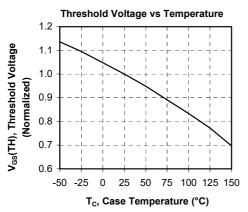


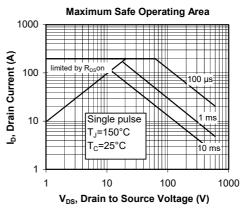


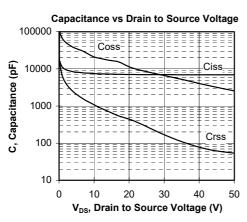


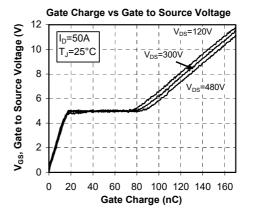




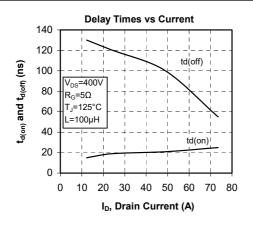


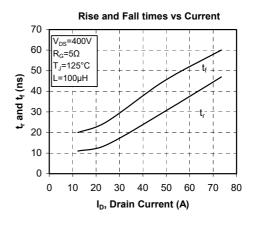


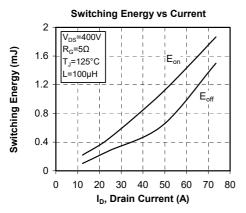


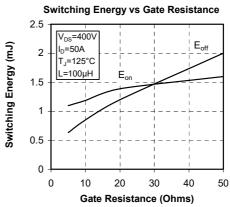


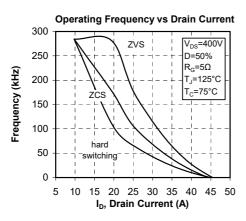


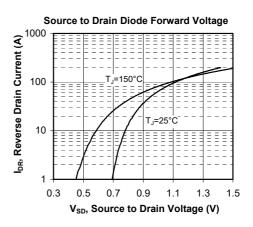














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